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Magnetic and structural properties of ion nitrided stainless steel

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The magnetic properties and crystalline structure of expanded austenite obtained by ion beam nitriding of AISI 316 steel are investigated. Magnetic force microscopy reveals that the nitrogen expanded austenite has two different layers, an outermost ferromagnetic layer and a paramagnetic layer beneath it. Superimposing the nitrogen concentration profile determined by secondary neutral mass spectrometry and the magnetic force microscopy image, one can see that the paramagnetic-ferromagnetic transition takes place at the inflection point of the nitrogen concentration profile at about 14 ± 2 N at. %. Conventional and glancing angle x-ray diffraction suggests that nitrogen could occupy first tetrahedral interstitial positions (nitrogen-poor paramagnetic phase) and then, after saturation of Cr traps, octahedral interstitial positions (nitrogen-rich ferromagnetic phase). The ferromagnetic-paramagnetic transition is seen to be governed by Cr (traps)—N interactions. © 2009 American Institute of Physics.

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I. INTRODUCTION

Plasma surface modification of materials is commonly used to increase hardness, to improve wear and corrosion resistance, and to reduce friction. 1-3 Plasma nitriding of austenitic stainless steel, in particular, attracted strong interest owing to the formation of the expanded austenite (S, γ_N , or m phase), a nitrogen-supersaturated compound with fcc-like crystalline structure.⁴ A wealth of research was devoted to explain the nature of expanded austenite, so far without a satisfactory understanding of its formation and structure.^{5–11} According to literature, the expanded austenite is the main phase in different austenitic stainless steel surfaces after nitrogen (N) ion implantation. 12 It was recently suggested the presence of two different phases in the nitrided layer. 12,13 Furthermore, low-iron metal alloys with fcc-like structure such as Inconel also presented the formation of two different expanded austenite phases.¹⁴ Magnetic force microscopy (MFM) was used to show that the outermost layer is ferromagnetic and covers up to 80% of the total nitrided layer thickness, 15 whereas the inner layer was shown to be paramagnetic, similar to the bulk material (austenitic stainless steel AISI 316). In addition, it is well established that nitrogen in expanded austenite is located in interstitial sites, forming a solid solution, and in the vicinity of chromium (Cr) atoms. 16 In fact, Cr atoms act as traps for nitrogen due to their high chemical affinity. 17-19

The fcc-like crystalline structure of the N-supersaturated compound is not isotropic. The (200) anomalous expansion in the fcc crystalline structure 20,21 and the plastic deformation that takes place in nitrided austenitic stainless steel 22 are strong evidences that Cr–N interaction plays a significant role in the transition from the original austenitic phase to the final expanded austenitic phase. However, atomic-scale investigation of the occurrence of this phase transition as well as on the location of N (octahedral and/or tetrahedral sites) and on how N can produce anisotropic distortions in fcc-like structures are still needed.

This paper aims at a better understanding of the structure and properties of expanded austenite formed by ion beam nitriding of austenitic stainless steel, in particular, the magnetic properties, crystalline structure, and nitrogen transport and incorporation.

II. EXPERIMENTAL

Mirror polished samples of AISI 316 stainless steel (C: <0.08, Si: <0.5, P: 0.05, S: 0.03, Mn: 1.6, Mo: 2.1, Ni: 12.0, Cr: 17.0, Fe: balance in wt. %) were used. Nitriding was performed in an ion implantation chamber equipped with a 30 mm diameter dc Kaufman ion source. ^{23,24} Nominal ion beam energy and current density were fixed at 600 eV and 1.2 mA cm⁻², respectively. ^{25,26} The background chamber pressure is 10^{-5} Pa $(PO_2 < 2 \times 10^{-6}$ Pa) and the nitrogen working pressure was fixed at 10^{-2} Pa. The feeding gas of the Kaufman ion source is trough mass flowmeter controllers and the ion incidence perpendicular to the sample surface.

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The substrate temperature during implantation was 380 ± 10 °C. Nitriding time was varied from 5 to 120 min. X-ray diffraction (XRD) analyses were performed using a Siemens D500 X-ray diffractometer with Co $K\alpha$ radiation in glancing incidence angle (GIXRD) and in Bragg-Brentano (BB), θ -2 θ geometry. The N concentration profiles were determined by secondary neutral mass spectrometry (SNMS). A 5–8 keV Ar⁺ beam was used to produce 250 or 500 μ m² craters. The depth of each sputtered crater was measured with a high precision profilometer in order to calibrate the depth scale.²⁷ Nitrogen was quantified by calibrating against a γ' -Fe₄N standard. The morphology of the samples was analyzed by cross-section scanning electron microscopy (SEM), atomic force microscopy (AFM), and MFM. SEM analyses were performed in a JEOL JSM-5900LV apparatus. In order to reveal the microstructure, the samples for SEM analyses were etched for 5 s in a $\sim 10\%$ marble solution, followed by rinsing in analytical alcohol to stop the etching. AFM and MFM analyses were performed using a Dimension 3000-Digital Instruments Corporation scanning-probe microscope. Unlike more conventional microscopies, this class of microscope generates images of the sample surface by raster scanning a fine-tipped probe over a region of up to 100 μ m². A Co–Ni alloy coated tip was used for magnetic measurements.

III. RESULTS

Figures 1(a)–1(c) show, respectively, cross-section SEM, AFM, and MFM images of the sample nitrided for 120 min. The surface is on the left-hand side of the images. Figure 1(a) shows a SEM image in secondary electron mode, indicating a homogenous nitrided layer. The AFM image, Fig. 1(b), on the other hand, indicates a depression at the end of the nitrided layer, visualized as a darker zone in the middle region of the image. Finally, the MFM image of Fig. 1(c) clearly reveals that the nitrided layer is divided in two well defined zones. The outermost zone is formed by domes and the inner zone is flat.

Figure 2 shows the N concentration profiles for different nitriding times as determined by SNMS. It is important to remark that the N content determined by SMNS is underestimated as compared to the one determined by XPS (not shown). The N profiles present two different characteristic regimes, namely, a slowly decreasing profile for the outermost layer (regime A) and a fastly decreasing one for the innermost layer (regime B). Both slopes are depicted by dashed lines, indicated by arrows, in Fig. 2 in the N profile for the sample nitrided during 120 min.

Figure 3 shows the XRD patterns for different nitriding times in BB θ -2 θ geometry. Increasing the nitriding time leads to an increase in the diffraction peaks, assigned to the expanded austenite (γ_N) with respect to the peak assigned to the original austenite (γ). One notices also from Fig. 3 that the intensity of plane γ_N -(200) increases with respect to that of γ_N -(111) for increasing nitriding times. In fact, for the 5 min nitriding time, only the peak associated with plane γ_N -(111) is clearly visible in the diffractogram.

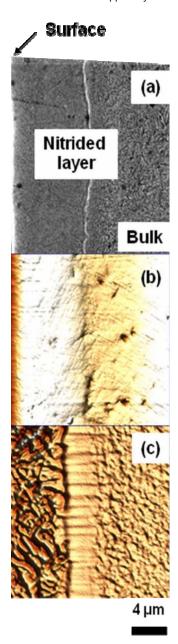


FIG. 1. (Color online) Cross-section images of the nitrided layer showing the morphology obtained by (a) SEM, (b) AFM, and (c) MFM.

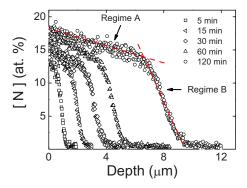


FIG. 2. (Color online) Nitrogen concentration as a function of depth for different nitriding times as determined by SNMS. Two dashed lines were drawn in the experimental curve for the sample nitrided for 120 min to indicate two different N transport regimes.

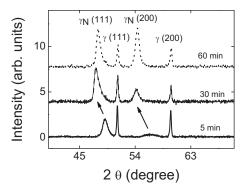


FIG. 3. X-ray diffractograms in BB θ -2 θ geometry for samples nitrided during different nitriding times.

IV. DISCUSSION

A. Morphology of expanded austenite

The three dimensional MFM image of Fig. 4 shows the magnetic domains of a ferromagnetic phase in the outermost part of the nitrided layer. The innermost part of the nitrided layer shows a paramagnetic phase, represented by a flat, nonmagnetic signal. Several authors observed the presence of ferromagnetism in nitrided ASS 316 steel.^{28–30} Interesting applications of magnetic properties in nitrided austenitic stainless steel have been demonstrated.³¹ Thus, the outermost layer is a nitrogen-rich ferromagnetic phase and the innermost layer is a nitrogen-poor paramagnetic phase. For clearness, Fig. 5 shows the superposition of the nitrogen profile and the MFM image of the nitrided layer for the same sample nitrided for 120 min, which allows establishing the correlation between the type of expanded austenite phase and its nitrogen content. From Fig. 5, one can see that the ferromagnetic-paramagnetic transition takes place around the inflection in the nitrogen profile. The N concentration determined here around the inflection point was approximately 14 ± 2 at. %, whereas previous nuclear reaction analysis

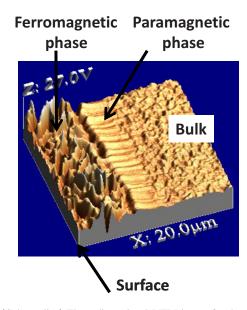


FIG. 4. (Color online) Three dimensional MFM image for the sample nitrided for 120 min. The peaks in the near-surface layer represent the magnetic domains of the ferromagnetic phase.

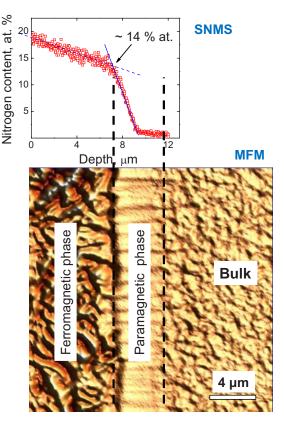


FIG. 5. (Color online) (Top) N concentration profile for the sample nitrided during 120 min as determined by SNMS. (Bottom) MFM image from the same sample, indicating two different magnetic phases in the nitrided layer (expanded austenite) at the left hand side. The dashed line is a guide to the eyes to connect the magnetic phase transition and the inflexion in the nitrogen content at 14 at. %.

work obtained about 17 N %. ¹⁸ One notices here that these inflections occur for N concentrations comparable to the Cr content of the steel, around 17 Cr %.

B. Magnetic properties of expanded austenite

ASS 316 is a paramagnetic alloy. Upon nitriding, the alloy remains paramagnetic up to a nitrogen content of approximately 14 at. %. For higher N concentrations, a ferromagnetic phase is formed. One can discuss the nature of this transition from para- to ferromagnetic phase. The magnetic properties of transition metals are due to the spin interactions of valence band electrons. In our case, electrons from 3d orbitals of Fe, Ni, and Cr control the magnetic properties of ASS 316. Furthermore, the paramagnetic-ferromagnetic transition dependence on N incorporation occurs by two different mechanisms, (i) the rearrangement of 3d electrons after changing the Fe-Cr-Ni atomic distances and/or (ii) the formation of metallic nitrides (MeN, Me=Fe, Cr, Ni). Concerning the first mechanism, it was shown³² that a local ferromagnetism in ASS 316 is generated by nanoindentation, which leads to a phase transition to ferromagnetic bct martensite. As for the second mechanism, all types of iron nitrides (Fe₁₆N₂, Fe₄N, Fe₂₋₃N) are ferromagnetic. 33-37 Thus, both factors are apparently acting in the system investigated in the present work. However, since the nitrogen concentration at the inflection point compares well with the chromium concentration, one can think of a first stage where nitrogen

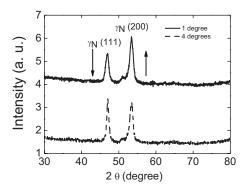


FIG. 6. X-ray diffractograms for the sample nitrided during 120 min in glancing incidences of 1° and 4°. The arrows indicate the changes in the intensity of planes (200) and (111), respectively.

bonds rapidly and preferentially to Cr (see regime B in Fig. 2), owing to the higher heat of formation of CrN than FeN_x and NiN_x (chemical trap).³⁸ Consequently, nitrogen removes Cr 3d electrons from the metallic alloy valence band. Since pure Cr is a paramagnetic metal, whereas pure iron and nickel are ferromagnetic,³⁹ a metal alloy containing iron and nickel should yield a ferromagnetic phase. 40,41 In addition, fcc-(Fe_{1-x}Ni_x)₄N is also ferromagnetic and the higher the iron content the higher the magnetic moment of this nitrided metal alloy. 42 Consequently, a rule of mixture for the magnetic moments might be used in this case because nickel is less ferromagnetic than iron.³⁹ We argue that the most important effect governing the ferromagnetism of the expanded austenite above 14 N at. % is the N-Cr interaction, which removes the chromium 3d electrons from the metal alloy valence band.

C. Crystalline structure of expanded austenite

The crystalline structure of nitrogen expanded austenite is not fully described yet. It is generally accepted that expanded austenite is a distorted fcc-like phase with anisotropic expansion due to internal stress. 43 However, the question on where nitrogen is located still remains unanswered. Further XRD diffraction analyses were undertaken aiming at clarifying this point. Figure 6 shows x-ray diffractograms at glancing incidences (GIXRD) of 1° and 4°, for the sample nitrided during 120 min. These incidence angles provide information on layers 0.5 and 2 μ m below the surface, respectively. Thus, from Fig. 6 one notices that the intensity of the diffraction peak associated with the γ_N -(200) plane is higher near the surface. In addition, as shown in Fig. 3, the intensity associated with the plane (200) increases with the increase in nitriding time, or in other words with the increase in N concentration. Hence, either in the analysis of the same sample by GIXRD or in the analysis of different samples by conventional BB geometry, the higher the nitrogen content the higher the intensity of plane (200).

Simulations of x-ray diffractograms with the Power Cell 2.4 (Ref. 44) code shows that nitrogen in interstitial sites modulates the intensity of peaks, for example, in the (111) versus (200) planes. 45 As more nitrogen is located in tetrahedral (or octahedral) interstitial sites, the intensity of constructive interference associated with plane (111) [or (200)] in-

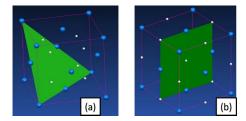


FIG. 7. (Color online) Ideal fcc crystalline structures with plane (111) crossing nitrogen in tetrahedral (a) and plane (200) crossing nitrogen in octahedral (b) interstitial sites.

creases. Figures 7(a) and 7(b) show two ideal fcc crystalline structures with plane (111) crossing N in tetrahedral and plane (200) crossing N in octahedral interstitial sites (white dots), respectively. Considering these simulations and the results of Fig. 6, one can conclude that, in near-surface expanded austenite, most of the nitrogen should be located at octahedral sites. The same is observed in Fig. 3, where the relative intensity of plane (200) increases with the increase in nitriding time. Figure 8 shows the diffraction intensity ratio for planes (111)/(200) as a function of nitriding time, where the intensity ratio is seen to decrease as the nitriding time increases. In other words, more nitrogen should incorporate in octahedral positions at longer nitriding times. This scenario suggests that at lower nitriding times, when only the intensity associated with the (111) plane is significative, most of the nitrogen should occupy tetrahedral positions due to the minimization of Cr-N distances, forming nanoclusters of CrN up to saturation of all Cr traps (nitrogen-poor paramagnetic phase). 16 Then, by increasing the N concentration, it should be incorporated in octahedral positions (nitrogen-rich ferromagnetic phase). In fact, one single analytical technique is not sufficient to establish the exact position of nitrogen in the expanded austenite. Therefore, new characterizations by conversion electron Mossbauer scattering and high resolution transmission electron microscopy are being performed and will make the subject of a forthcoming publication.

V. CONCLUSIONS

Magnetic and structural properties of expanded austenite produced by ion beam nitriding are reported. Two different magnetic layers were observed, the outermost one being ferromagnetic and the innermost one paramagnetic. The nitro-

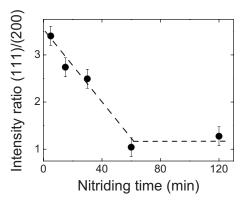


FIG. 8. I_{111}/I_{200} intensity ratio as a function of nitriding time.

gen concentration profiles present two well-distinguished regimes. The inflection point between them is situated approximately at the same depth as that of the transition from the ferromagnetic to the paramagnetic phase layer, around 14 ± 2 N at. %. The transition from the ferromagnetic to the paramagnetic phase layer is attributed to a mechanism governed by the strong chromium-nitrogen interaction. XRD experimental results and simulations suggest that at the beginning of the expanded austenite formation, nitrogen is mostly located in tetrahedral interstitial positions (nitrogen-poor paramagnetic phase). The increase in nitrogen concentration leads to saturation of chromium traps, which causes nitrogen to be incorporated in octahedral interstitial positions (nitrogen-rich ferromagnetic phase). The Cr–N interaction removes the Cr 3d electrons from the metal alloy

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